Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/685,176	GUPTA ET AL.	
	Examiner	Art Unit	
	Eva Yi Zheng	2611	

ISSUE CLASSIFICATION

ORIGINAL						CROSS REFERENCE(S)						
CLASS				SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
375				355	375	371	354	373	356			
INTERNATIONAL CLASSIFICATION					326	96	96					
H	0	4	L	7/00	327	144	141					
				/	713	400	500	501	600			
				/								
				/								
				/								

Eva Zheng 5/25/07
(Assistant Examiner) (Date)

(Legal Instruments Examiner) (Date)

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SUPERVISORY PATENT EXAMINER
(Primary Examiner) (Date) 5/25/07

Total Claims Allowed: 29

O.G. Print Claim(s)	O.G. Print Fig.
1	1

☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1	28	31		61		91		121		151		181
	2	29	32		62		92		122		152		182
	3		33		63		93		123		153		183
	4		34		64		94		124		154		184
2	5		35		65		95		125		155		185
3	6		36		66		96		126		156		186
4	7		37		67		97		127		157		187
5	8		38		68		98		128		158		188
6	9		39		69		99		129		159		189
7	10		40		70		100		130		160		190
8	11		41		71		101		131		161		191
9	12		42		72		102		132		162		192
10	13		43		73		103		133		163		193
11	14		44		74		104		134		164		194
12	15		45		75		105		135		165		195
13	16		46		76		106		136		166		196
14	17		47		77		107		137		167		197
15	18		48		78		108		138		168		198
16	19		49		79		109		139		169		199
17	20		50		80		110		140		170		200
18	21		51		81		111		141		171		201
19	22		52		82		112		142		172		202
20	23		53		83		113		143		173		203
21	24		54		84		114		144		174		204
22	25		55		85		115		145		175		205
23	26		56		86		116		146		176		206
24	27		57		87		117		147		177		207
25	28		58		88		118		148		178		208
26	29		59		89		119		149		179		209
27	30		60		90		120		150		180		210